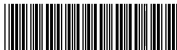


Search Notes**Application/Control No.**

10/826,067

Applicant(s)/Patent under Reexamination

WALSH ET AL.

Examiner

Ted M. Wang

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	376, 373	8/2/2008	TW
375	327	8/2/2008	TW
327	156	8/2/2008	TW
331	1A, 25	8/2/2008	TW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	376	8/2/2008	TW
375	373, 327	8/2/2008	TW
327	156	8/2/2008	TW
331/1A, 25		5/2/2008	TW

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	8/2/2008	TW
ODP- searched and reviewed from EAST and PALM	8/2/2008	TW
IEEEExplor- Advance -fraction* synthesizer and interpolat*	8/2/2008	TW
IEEEExplor- author -Walsh P., Keaveney M	8/2/2008	TW